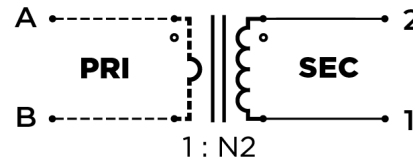


TEST CONDITIONS

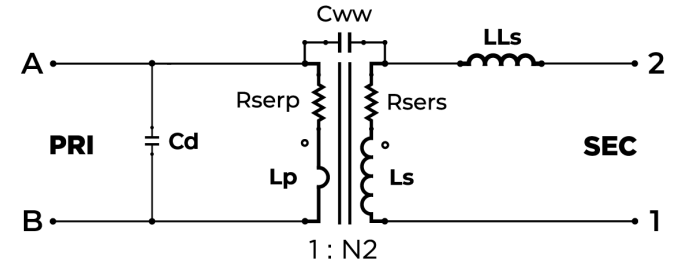
Inductance (L): 1 kHz, 1 V_{RMS}, Series
Leakage Inductance (LLs): 1 kHz, 1 V_{RMS}, Series
Interwinding Capacitance (Cww): —
Series Resistance (Rser): Measured at 25 °C
Cd: Measured by HP4194A equivalent A on secondary

EQUIPMENTS: 4194A, 4285A, 4284A, HOIKI 3541

SCHEMATIC SYMBOL



EQUIVALENT CIRCUIT



Part Number	Lp (A-B)	Ls (2-1)	Rserp	Rsers (2-1)	Cd	Cww	S.R.F (2-1)	LLs (2-1) Shorted (A-B)	Turn Ratio
	<i>uH, Typ.</i>	<i>H, Typ.</i>	<i>n/a</i>	Ω , <i>Typ.</i>	<i>pF, Typ.</i>	<i>n/a</i>	<i>kHz, Typ.</i>	<i>mH, Typ.</i>	<i>(A-B) : (2-1)</i>
CT08-1200	13.19	19.00	N/A	31.54	63.20	N/A	4.67	786.00	1:1200